

## Refine Search

### Search Results -

Terms	Documents
L10 and L12	30

Database:

US Pre-Grant Publication Full-Text Database  
 US Patents Full-Text Database  
 US OCR Full-Text Database  
 EPO Abstracts Database  
 JPO Abstracts Database  
 Derwent World Patents Index  
 IBM Technical Disclosure Bulletins

Search:





### Search History

DATE: Friday, December 29, 2006    [Purge Queries](#)    [Printable Copy](#)    [Create Case](#)

**Set Name**   **Query**  
 side by side

**Hit Count**   **Set Name**  
 result set

*DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR*

<u>L13</u>	l10 and L12	30	<u>L13</u>
<u>L12</u>	l7 or l9	41	<u>L12</u>
<u>L11</u>	(l7 or l9) and l10	30	<u>L11</u>
<u>L10</u>	@ad<20031229	25234274	<u>L10</u>
<u>L9</u>	l6 and L8	39	<u>L9</u>
<u>L8</u>	714/\$.ccls.	57412	<u>L8</u>
<u>L7</u>	l1 and L6	9	<u>L7</u>
<u>L6</u>	l4 and L5	52	<u>L6</u>
<u>L5</u>	select\$5 near5 (scan chain\$1)	84819	<u>L5</u>
<u>L4</u>	(debug\$5 near3 signal\$1) and l3	156	<u>L4</u>
<u>L3</u>	(scan chain\$5) same l2	7943	<u>L3</u>
<u>L2</u>	(debug\$5 or test\$5) near3 (integrated circuit\$1)	121409	<u>L2</u>
<u>L1</u>	debug\$5 near3 soc	109	<u>L1</u>

END OF SEARCH HISTORY